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| | | | | Application Number | 10/698,822-Conf. #1260 | |
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| DISCLOSURE STATEMENT BY APPLICANT | | | | First Named Inventor | Paul C. ALLEN | |
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| | | | | Examiner Name | B. N. Thomas | |
| Sheet | 1 | of | 1 | Attorney Docket Number | 0107262.00184US2 | |

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| Examiner Signature | /Brandi Thomas/ | Date Considered | 06/10/2008 |
|-----------------------|-----------------|--------------------|------------|



Applicant's unique citation designation number (optional). Applicant is to place a check mark here if English language Translation is attached.